July 2008

FDW2503NZ

Dual N-Channel 2.5V Specified PowerTrench[®] MOSFET

General Description

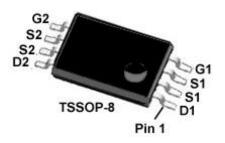
This NChannel 2.5V specified MOSFET is a rugged gate version of Fairchild Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (2.5V - 12V).

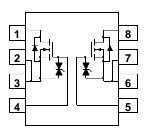
Applications

- Load switch
- Motor drive
- DC/DC conversion
- Power management

Features

- 5.5 A, 20 V. $R_{DS(ON)} = 20 \text{ m}\Omega @ V_{GS} = 4.5V$ $R_{DS(ON)} = 26 \text{ m}\Omega @ V_{GS} = 2.5V$
- Extended V_{GSS} range (±12V) for battery applications
- ESD protection diode (note 3)
- + High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- Low profile TSSOP-8 package





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		20	V
V _{GSS}	Gate-Source Voltage		±12	V
D	Drain Current – Continuous	(Note 1a)	5.5	A
	– Pulsed		30	
PD	Power Dissipation	(Note 1a)	1.0	W
		(Note 1b)	0.6	
T _J , T _{STG}	Operating and Storage Junction Temperatu	re Range	-55 to +150	°C
Therma	I Characteristics			
R _{0JA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	100	°C/W
		(Note 1b)	125	

Device Marking	Device	Reel Size	Tape width	Quantity
2503NZ	FDW2503NZ	13"	12mm	2500 units

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics	1				
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$	20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C		14		mV/ºC
DSS	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 16 \text{ V}, V_{\text{GS}} = 0 \text{ V}$			1	μA
GSSF	Gate–Body Leakage, Forward	$V_{GS} = 12 \text{ V}, V_{DS} = 0 \text{ V}$			10	μA
GSSR	Gate–Body Leakage, Reverse	$V_{GS} = -12 V$, $V_{DS} = 0 V$			-10	μA
On Char	acteristics (Note 2)	· · · · · · · · · · · · · · · · · · ·				
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.6	1.0	1.5	V
$\Delta V_{GS(th)} \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$, Referenced to 25°C		-3		mV/ºC
R _{DS(on)}	Static Drain–Source On–Resistance	$ \begin{array}{l} V_{GS} = 4.5 \ V, I_D = 5.5 \ A \\ V_{GS} = 2.5 \ V, I_D = 5 \ A \\ V_{GS} = 4.5 \ V, \ I_D = 5.5 \ A, \ T_J = 125^\circ C \end{array} $		14 19 19	20 26 29	mΩ
D(on)	On-State Drain Current	$V_{GS} = 4.5 V$, $V_{DS} = 5 V$	30			Α
g fs	Forward Transconductance	$V_{DS} = 5 V$, $I_D = 5.5 A$		30		S
Dynamic	Characteristics	· · · · · · · · · · · · · · · · · · ·				
Ciss	Input Capacitance	$V_{DS} = 10 V$, $V_{GS} = 0 V$,		1286		pF
Coss	Output Capacitance	f = 1.0 MHz		305		pF
C _{rss}	Reverse Transfer Capacitance			161		pF
Switchir	g Characteristics (Note 2)					
t _{d(on)}	Turn–On Delay Time	$V_{DD} = 10 V$, $I_D = 1 A$,		10	20	ns
tr	Turn–On Rise Time	$V_{GS}=4.5~V,\qquad R_{GEN}=6~\Omega$		14	25	ns
t _{d(off)}	Turn–Off Delay Time			25	40	ns
t _f	Turn–Off Fall Time			8	16	ns
Qg	Total Gate Charge	$V_{DS} = 10 \text{ V}, \qquad I_D = 5.5 \text{ A},$		12	17	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 4.5 V$		2.6		nC
Q _{gd}	Gate–Drain Charge	1		3		nC
Drain-S	ource Diode Characteristics a	and Maximum Ratings		•	•	•
ls	Maximum Continuous Drain–Source I				1.0	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$, $I_S = 1.0 A$ (Note 2)		0.7	1.2	V

Notes:

 R_{qub} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{quc} is guaranteed by design while R_{BCA} is determined by the user's board design.

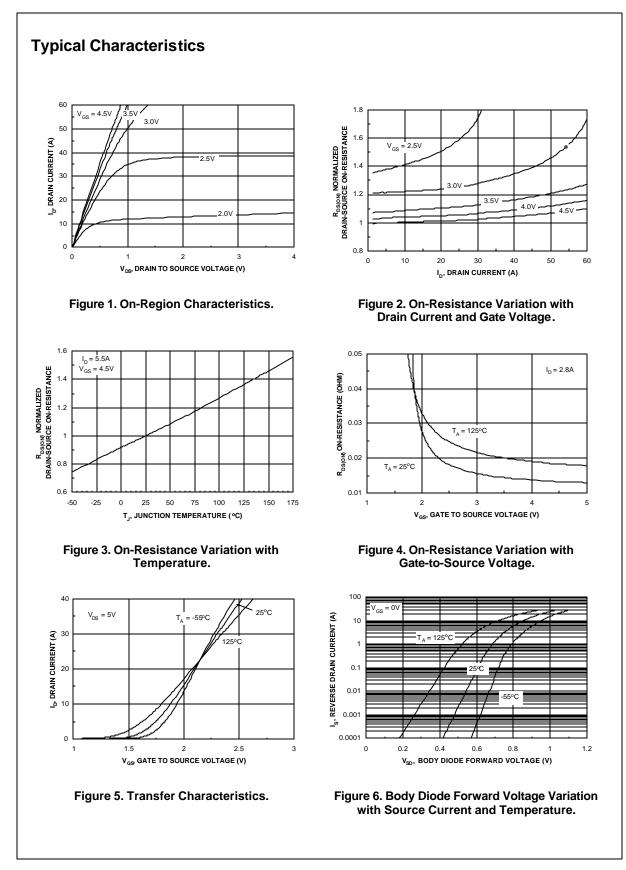
a) $R_{\rm BJA}$ is 100°C/W (steady state) when mounted on a 1 inch² copper pad on FR-4.

b) $R_{\theta JA}$ is 125°C/W (steady state) when mounted on a minimum copper pad on FR-4.

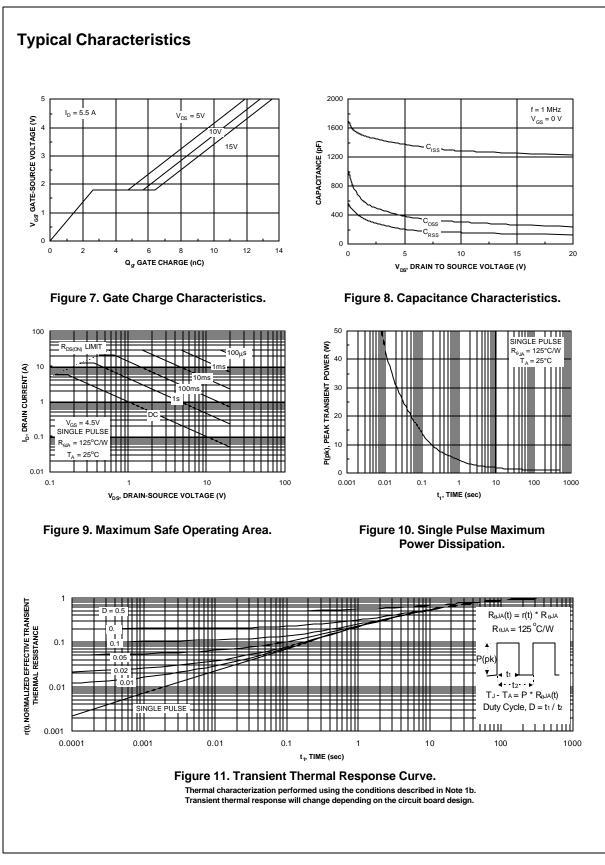
2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

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FDW2503NZ Rev C1(W)



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